

Notice of References Cited

Application/Control No.

10/561,617

Applicant(s)/Patent Under
Reexamination
YOSHIDA, NAOKI

Examiner

Pinkal R. Chokshi

Art Unit

2425

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0093806	05-2003	Dureau et al.	725/107
*	B	US-2010/0057813	03-2010	ABE et al.	707/781
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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NON-PATENT DOCUMENTS

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